


<b>Search Notes</b> 	<b>Application/Control No.</b> 10791504	<b>Applicant(s)/Patent Under Reexamination</b> CHIANG ET AL.
	<b>Examiner</b> 307ANISH DESAI	<b>Art Unit</b> 1794

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search using EAST	11/10/08	APD
Text search (all databases except USOCR)	11/10/08	APD
428/304.4,319.3,307/400,367/170 (USPAT and USPGPUB-text search only)	11/12/2008	APD
Text search (all databases except USOCR)	11/12/2008	APD
Interference search (see interference search history printout)	11/12/2008	APD
428/304.4,319.3,307/400,367/170 (Interference search using EAST)	11/12/08	APD
Allowance consultation with Primary Examiner	11/11/08	APD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
428	304.4	11/12/08	APD
428	319.3, 319.7, 305.5	11/12/08	APD
367	170	11/12/08	APD
307	400	11/12/08	APD

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